

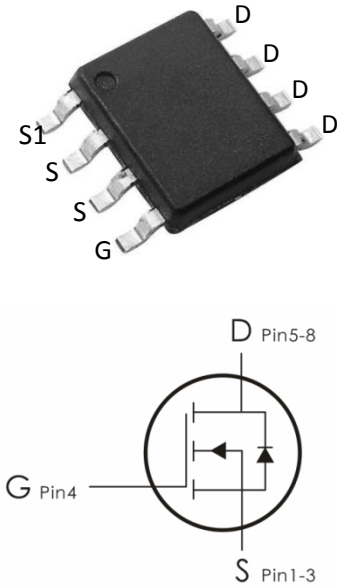
Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=30V, I_D=20A, R_{DS(on)} < 6.5m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous ($T_A=25^\circ\text{C}$)	20	A
	Drain Current - Continuous ($T_A=75^\circ\text{C}$)	15.2	
I_{DM}	Drain Current - Pulsed ^① ($T_A=25^\circ\text{C}$)	76	
I_S	Diode continuous forward current ($T_A=25^\circ\text{C}$)	5	
P_D	Power Dissipation ($T_A=25^\circ\text{C}$)	3.1	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-50 to +150	$^\circ\text{C}$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	$^\circ\text{C}/\text{W}$

Package Marking and Ordering Information:

Part NO.	Marking	Package
DOS20N03	20N03	SOP-8

Electrical Characteristics: ($T_J=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250 μ A	30	---	---	V
I _{DSS}	Drain-Source Leakage Current(T _A =25℃)	V _{DS} =30V , V _{GS} =0V	---	---	1	μA
	Drain-Source Leakage Current(T _A =125℃)	V _{DS} =24V , V _{GS} =0V	---	---	100	μA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =± 20V, V _{DS} =0V	---	---	± 100	nA
On Characteristics						
V _{GS(th)}	GATE-Source Threshold Voltage	V _{GS} =V _{DS} , I _D =250 μ A	1	1.6	2.5	V
R _{DS(on)}	Static Drain-Source On Resistance②	V _{GS} =10V, I _D =15A	---	5.2	6.5	m Ω
		V _{GS} =4.5V, I _D =8A	---	7.5	9.5	m Ω
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz	---	1320	---	pF
C _{oss}	Output Capacitance		---	205	---	
C _{rss}	Reverse Transfer Capacitance		---	135	---	
R _g	Gate Resistance	f=1MHz	---	4.4	---	Ω
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} =15V, I _D =3A R _G =3.3 Ω , V _{GS} =10V	---	11	---	ns
t _r	Rise Time		---	30	---	ns
t _{d(off)}	Turn-Off Delay Time		---	24	---	ns
t _f	Fall Time		---	8	---	ns
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =15A	---	23.5	---	nC
Q _{gs}	Gate-Source Charge		---	3.3	---	nC
Q _{gd}	Gate-Drain “Miller” Charge		---	4.8	---	nC
Drain-Source Diode Characteristics						
V _{SD}	Source-Drain Diode Forward Voltage②	V _{GS} =0V, I _{SD} =12A	---	0.81	1.2	V

T_{rr}	Body Diode Reverse Recovery Time	$I_{SD}=10A, V_{GS}=0V$ $di/dt=100A/\mu s$	---	31	---	Ns
Q_{rr}	Body Diode Reverse Recovery Charge		---	20	---	Nc

Notes:

- ① Pulse width limited by maximum allowable junction temperature
- ② Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.

Typical Characteristics: ($T_c=25^\circ C$ unless otherwise noted)

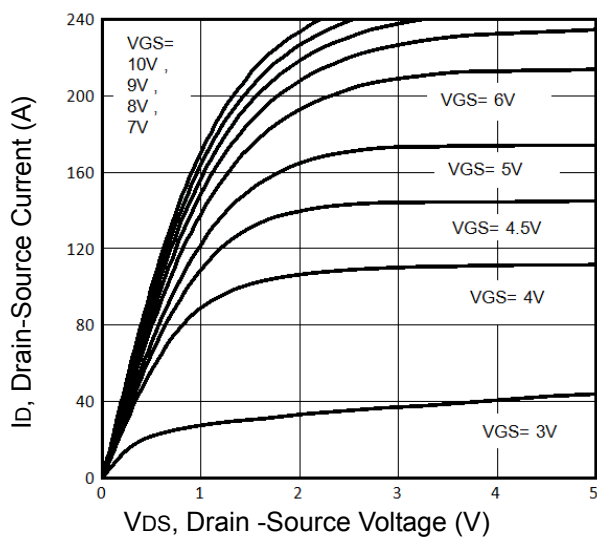


Fig1. Typical Output Characteristics

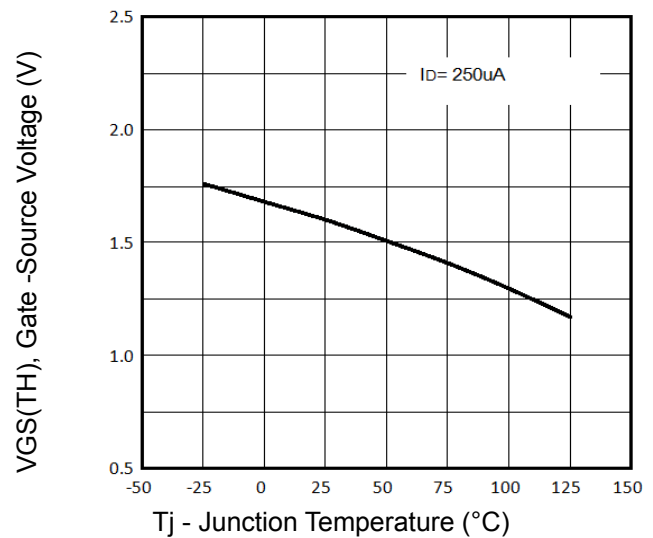


Fig2. VGS(TH) Voltage Vs. Temperature

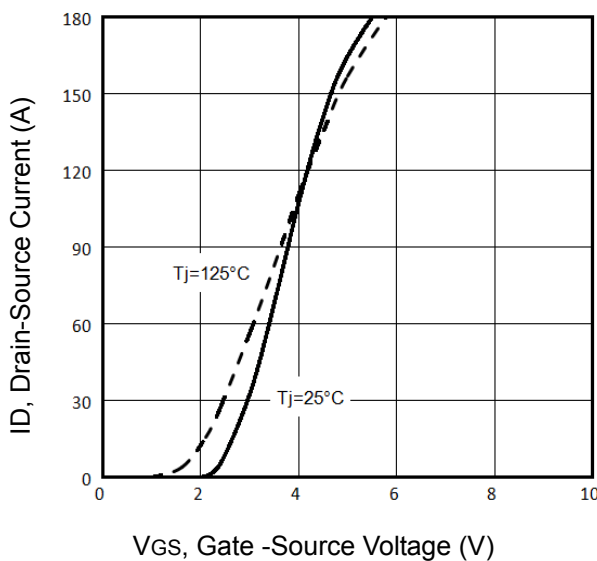


Fig3. Typical Transfer Characteristics

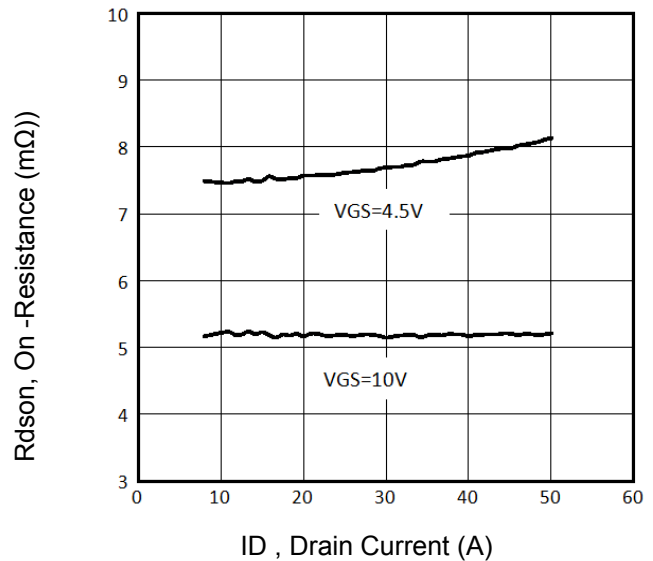


Fig4. On-Resistance vs. Drain Current and Gate Voltage

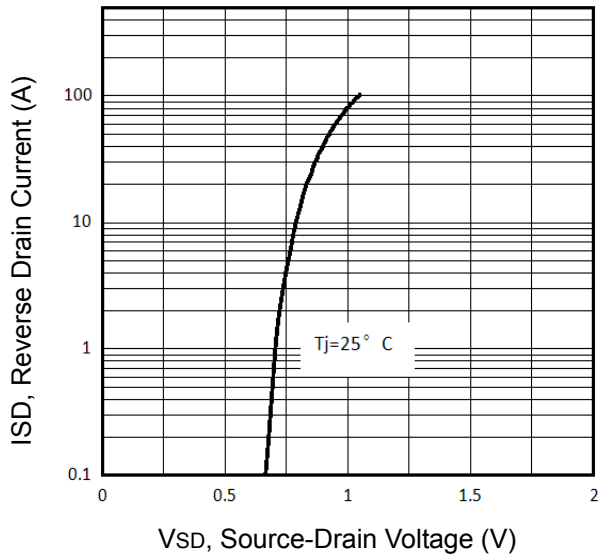


Fig5. Typical Source-Drain Diode Forward Voltage

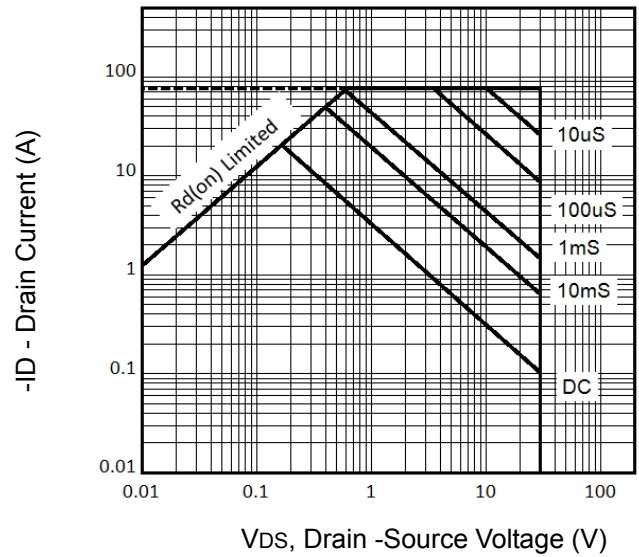


Fig6. Maximum Safe Operating Area

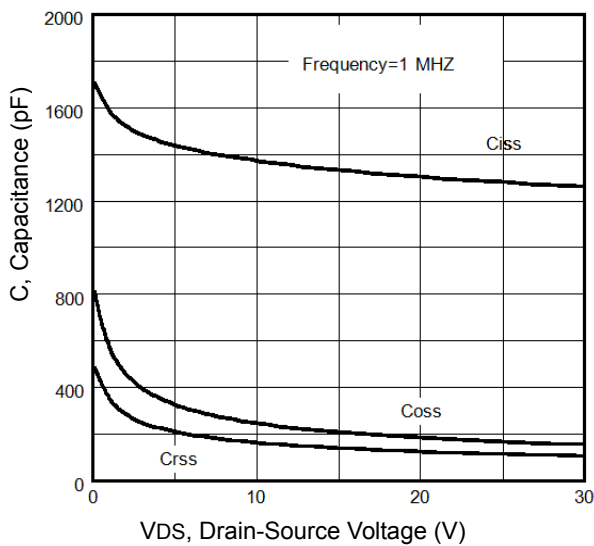


Fig7. Typical Capacitance Vs. Drain-Source Voltage

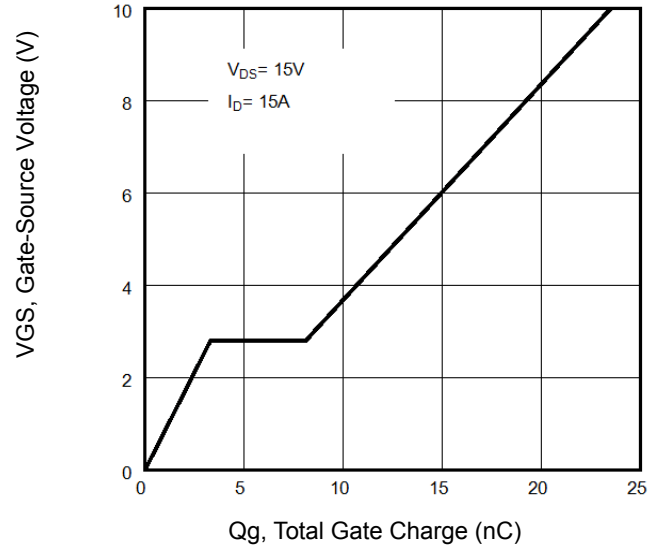


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

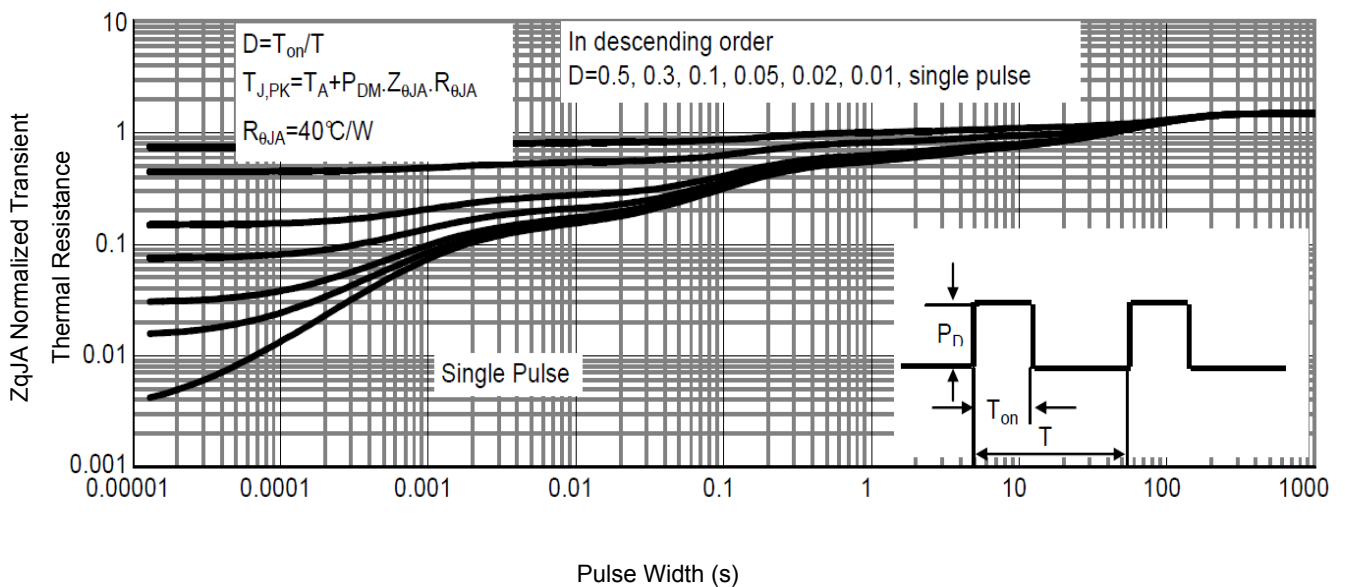


Fig9. Normalized Maximum Transient Thermal Impedance